IN THE CLAIMS:

Please cancel claims 1-6 without prejudice or disclaimer. Please amend claim 7 as follows. Please add new claims 12-14 as follows. A detailed listing of all claims is as follows.

Claims 1-6 (Canceled).

Claim 7 (Currently Amended): A package substrate electrolytically plated with Au without using any plating lead line, comprising:

a base substrate formed with a plurality of through holes;

a first copper plated layer plated on predetermined portions of the base substrate and inner surfaces of the through holes;

a plated pattern layer formed on the first copper plated layer, the plated pattern layer including a second copper plated layer formed on portions of the first copper plated layer;

wire bonding pads formed on predetermined portions of the plated pattern layer at an upper surface of the base substrate, the wire bonding pads including in accordance with an electrolytic Au plating process without using any and not connected to a remnant of a plating lead line;

solder ball pads formed on predetermined portions of the plated pattern layer at a lower surface of the base substrate, the solder ball pads including in accordance with an electrolytic Au plating process without using any and not connected to a remnant of a plating lead line; and

a solder resist covering the base substrate and the plated pattern layer, except for the wire bonding pads and the solder ball pads,

the plated pattern layer being formed by coating a resist on the first copper plated layer, except for regions around the through holes, and forming a second copper plated layer in a semi-additive manner on portions of the first copper plated layer at which the resist is not present.

Claim 8 (Original): The package substrate according to claim 7, wherein the wire bonding pads and the solder ball pads are Au layers plated in accordance with application of current to the first copper plated layer.

Claim 9 (Original): The package substrate according to claim 7, wherein the first copper plated layer serves as a plating lead line during the electrolytic Au plating processes for the solder ball pads and the wire bonding pads.

Claim 10 (Original): The package substrate according to claim 7, wherein each of the electrolytic Au plating process forms a plated layer having a thickness of 0.5 to 1.5 µm.

Claim 11 (Original): The package substrate according to claim 7, wherein the first copper plated layer is an electroless copper plated layer.

Claim 12 (New): The package substrate according to claim 7, wherein the base substrate is a copper clad laminate (CCL).

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Claim 13 (New): The package substrate according to claim 7, wherein the solder resist

covers portions of the wire bonding pads or the solder ball pads, and exposes other portions of

the wire bonding pads or the solder ball pads.

Claim 14 (New): The package substrate according to claim 7, wherein the second

copper plated layer fills the through holes.